Application/Control No. Applicant(s)/Patent Under Reexamination 09/886,064 HAITSMA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2131 Shin-Hon Chen **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,332,194 12-2001 Bloom et al. 713/176 Α * US-6,216,228 04-2001 Chapman et al. 713/176 В US-С US-D US-Ε US-F US-G US-Н US-1 J US-K US-US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Classification Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s

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